

Search Notes

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Examiner

Tomasz Ponikiewski

Applicant(s)/Patent under
Reexamination

MEYER, FRANK

Art Unit

2165

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/2/2006	TP
Checked East DB for double patenting	10/2/2006	TP
USPT, PGPB,JPAB,EPO,DWPI,TDBG	10/2/2006	TP
Consulted with Neveen Abel-Jalil	10/2/2006	TP